

<Intelligent Power Modules>

## PM75CG1B120

**FLAT-BASE TYPE INSULATED PACKAGE** 



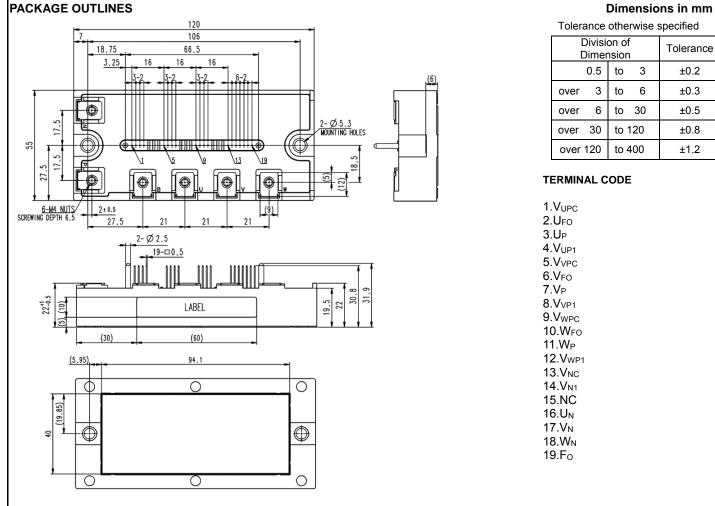
#### **FEATURE**

- a) Adopting Full-Gate CSTBT™ chip.
- b) The over-temperature protection which detects the chip surface temperature of CSTBT™ is adopted.
- c) Error output signal is available from each protection upper and lower arm of IPM.
- d) Outputting an error signal corresponding to the abnormal state (error mode identification)

UL Recognized under UL1557, File No. E323585 This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU.

#### **APPLICATION**

General purpose inverter, servo drives and other motor controls



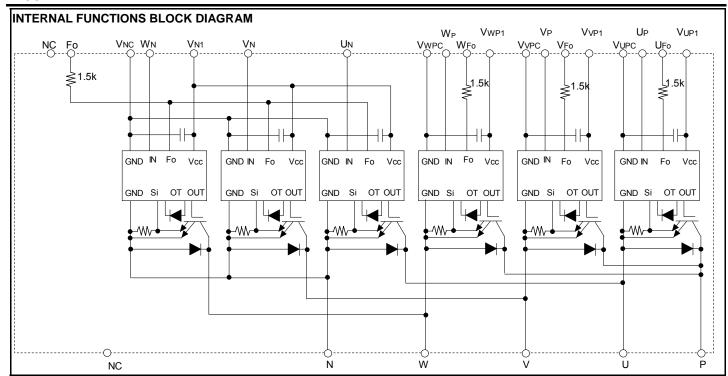
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Publication date: Nov. 2017

	Divisi Dimer	Tolerance		
	0.5	to	3	±0.2
over	3	to	6	±0.3
over	6	to	30	±0.5
over	30	to	120	±0.8
over	120	to 4	400	±1.2

HIGH POWER SWITCHING USE

**INSULATED TYPE** 



#### **MAXIMUM RATINGS** (Tvj = 25°C, unless otherwise noted)

#### **INVERTER PART**

Symbol	Parameter	Conditions	Ratings	Unit	
V <sub>CES</sub>	Collector-Emitter Voltage	V <sub>D</sub> =15 V, V <sub>CIN</sub> =15 V	1200	V	
I <sub>C</sub>	Collegator Comment	T <sub>C</sub> =25 °C			
I <sub>CRM</sub>	Collector Current	Pulse	150	A	
P <sub>tot</sub>	Total Power Dissipation	T <sub>C</sub> =25 °C	480	W	
l <sub>E</sub>	Emitter Current	T <sub>C</sub> =25 °C	75	^	
I <sub>ERM</sub>	(Free-wheeling Diode Forward current)	Pulse	150	Α	
Tvj	Junction Temperature		-20 ~ +150	°C	

<sup>\*:</sup> Tc measurement point is just under the chip.

#### **CONTROL PART**

Symbol	Parameter	Conditions	Ratings	Unit
$V_D$	Supply Voltage	Applied between: V <sub>UP1</sub> -V <sub>UPC</sub> , V <sub>VP1</sub> -V <sub>VPC</sub> , V <sub>WP1</sub> -V <sub>WPC</sub> , V <sub>N1</sub> -V <sub>NC</sub>	20	V
$V_{CIN}$	Input Voltage	Applied between: U <sub>P</sub> -V <sub>UPC</sub> , V <sub>P</sub> -V <sub>VPC</sub> , W <sub>P</sub> -V <sub>WPC</sub> , U <sub>N</sub> , V <sub>N</sub> , W <sub>N</sub> -V <sub>NC</sub>	20	V
$V_{FO}$	Fault Output Supply Voltage	Applied between: U <sub>FO</sub> -V <sub>UPC</sub> , V <sub>FO</sub> -V <sub>VPC</sub> , W <sub>FO</sub> -V <sub>WPC</sub> , Fo-V <sub>NC</sub>	20	V
I <sub>FO</sub>	Fault Output Current	Sink current at U <sub>FO</sub> , V <sub>FO</sub> , W <sub>FO</sub> , Fo terminals	20	mA

#### **TOTAL SYSTEM**

Symbol	Parameter	Conditions	Ratings	Unit
V <sub>CC(PROT)</sub>	Supply Voltage Protected by SC	V <sub>D</sub> =13.5 V~16.5 V, Inverter Part, Tvj=+125°C start	800	V
T <sub>stg</sub>	Storage Temperature	-	-40 ~ +125	°C
Tc	Operating Case Temperature	-	-20 ~ +125	°C
V <sub>isol</sub>	Isolation Voltage	60Hz, Sinusoidal, Charged part to Base plate, AC 1min, RMS	2500	V

<sup>\*:</sup> Tc measurement point is just under the chip.

HIGH POWER SWITCHING USE

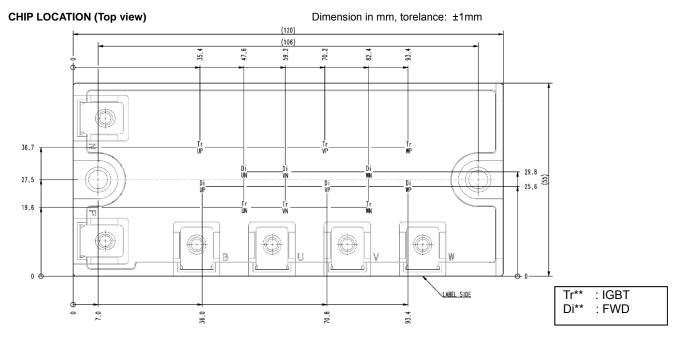
INSULATED TYPE

#### THERMAL RESISTANCE

Symbol	Parameter	Conditions	Limits			Unit
Syllibol	raiailletei	Conditions	Min.	Тур.	Max.	Offic
$R_{th(j-c)Q}$	Thermal Resistance	Junction to case, IGBT, per 1 element (Note1)		-	0.26	K/W
$R_{th(j-c)D}$	mermai Resistance	Junction to case, FWD, per 1 element (Note1)	-	-	0.38	N/VV
R <sub>th(c-s)</sub>	Contact Thermal Resistance	Case to heat sink, per 1 module,		14.4		K/kW
		Thermal grease applied (Note.1, 2)	- 14.4		-	IVKVV

Note1. If you use this value,  $R_{\text{th(s-a)}}$  should be measured just under the chips.

Note2. Typical value is measured by using thermally conductive grease of  $\lambda$ =0.9W/(m·K),  $D_{(C-S)}$ =50  $\mu$ m.



#### **ELECTRICAL CHARACTERISTICS** (Tvj= 25°C, unless otherwise noted)

#### **INVERTER PART**

Cumbal	Doromotor	Conditions			Limits			1.1
Symbol	Parameter				Min.	Тур.	Max.	Unit
		\/ _45\/   _75 A	T:-05 °C	Terminal	-	-	1.8	
\ /	Callegtor Emitter Seturation Voltage	$V_D = 15 \text{ V}, I_C = 75 \text{ A}$	Tvj=25 °C	Chip	-	1.3	-	V
V <sub>CEsat</sub>	Collector-Emitter Saturation Voltage	\/ =0\/ Dulgad (Fig. 1)	Tvj=125 °C	Terminal	-	-	2.05	V
		V <sub>CIN</sub> =0 V, Pulsed, (Fig.1)	1 Vj=125 C	Chip	-	1.5	-	
		V <sub>D</sub> =15 V, I <sub>E</sub> =75 A,	Tvj=25 °C	Terminal	-	-	2.4	V
V <sub>EC</sub>	Emitter-Collector Voltage	V <sub>D</sub> -13 V, I <sub>E</sub> -73 A,	1 Vj-25 C	Chip	-	1.75	1	
		V <sub>CIN</sub> = 15 V, pulsed, (Fig.2) Tvj=125 °C	Tyi=125 °C	Terminal	-	-	2.65	
			Chip	-	1.95	ı		
ton		$V_D$ =15 V, $V_{CIN}$ =0 V $\longleftrightarrow$ 15 V,			0.3	0.8	1.2	
t <sub>rr</sub>		V <sub>CC</sub> =600 V, I <sub>C</sub> =75A, Tvj=125 °C, Inductive Load			-	0.2	0.4	
t <sub>c(on)</sub>	Switching Time				-	0.2	0.4	μs
t <sub>off</sub>					-	1.1	2.8	
t <sub>c(off)</sub>		(Fig.3, 4)			-	0.4	1.2	
1	College of Consistent Cost off Comment	V <sub>CE</sub> =V <sub>CES</sub> , V <sub>D</sub> =15 V, V <sub>CIN</sub> =15 V (Fig.5)		Tvj=25 °C	-	-	1	^
CES	Collector-Emitter Cut-off Current			Tvj=125 °C	-	-	10	mA

HIGH POWER SWITCHING USE

INSULATED TYPE

#### **ELECTRICAL CHARACTERISTICS** (Tvj = 25°C, unless otherwise noted)

#### **CONTROL PART**

Cumbal	Parameter	Conditions		Limits			Unit
Symbol	Parameter	Conditions	Conditions		Тур.	Max.	Unit
		V -45 V V -45 V	V <sub>P1</sub> -V <sub>PC</sub>	-	4	6	
	Cinquit Cumant	V <sub>D</sub> =15 V, V <sub>CIN</sub> =15 V	V <sub>N1</sub> -V <sub>NC</sub>	-	12	18	
ID	Circuit Current	V <sub>D</sub> =15 V, V <sub>CIN</sub> =0 V ← 15 V, V <sub>CC</sub> =800 V	V <sub>P1</sub> -V <sub>PC</sub>	-	23	27	mA
		I <sub>C</sub> =0A, Tvj=125 °C, f <sub>C</sub> ≤20kHz	V <sub>N1</sub> -V <sub>NC</sub>	-	68	82	
$V_{th(ON)}$	Input ON Threshold Voltage	Applied between:	•	1.2	1.5	1.8	V
$V_{th(OFF)}$	Input OFF Threshold Voltage	$U_{P}$ - $V_{UPC}$ , $V_{P}$ - $V_{VPC}$ , $W_{P}$ - $V_{WPC}$ , $U_{N}$ , $V_{N}$ , $W_{N}$ - $V_{NC}$		1.7	2.0	2.3	V
SC	Short Circuit Trip Level	-20≤Tvj≤125 °C, V <sub>D</sub> =15 V (Fig.3, 6)		150	-	-	Α
t <sub>d(SC)</sub>	Short Circuit Current Delay Time	V <sub>D</sub> =15 V, Tvj=125 °C (Fig.3, 6)		-	2.0	-	μs
ОТ	Over Temperature Pretection	Data at tampo and top of IODT abis and	Trip level	150	-	-	°C
OT <sub>(hys)</sub>	Over Temperature Protection	Detect temperature of IGBT chip surface	Hysteresis	-	20	-	
UV <sub>t</sub>	Supply Circuit		Trip level	11.0	12.0	12.7	V
UV <sub>r</sub>	Under-Voltage Protection	-	Reset level	-	12.5	-	V
I <sub>FO(H)</sub>	Foult Output Current	V =15 V V =15 V (Note2)		-	-	0.01	m 1
I <sub>FO(L)</sub>	Fault Output Current	V <sub>D</sub> =15 V, V <sub>FO</sub> =15 V (Note3)		-	10	15	mA
			ОТ	-	8.0	-	ms
$t_{FO}$	Fault Output Pulse Width	V <sub>D</sub> =15 V (Note3)	UV	-	4.0	-	
			SC	-	2.0	-	

Note3. Fault output is given only when the internal SC, OT & UV protections schemes of either upper or lower arm device operate to protect it.

#### **MECHANICAL RATINGS AND CHARACTERISTICS**

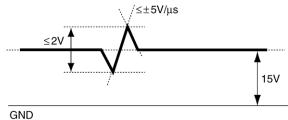
Symbol	Parameter	Conditions	Limits			Unit
Syllibol	Falametei	Conditions	Min.	Тур.	Max.	Offic
Ms	Mounting Torque	Mounting part screw : M5	2.5	3.0	3.5	N•m
$M_{t}$	Mounting Torque	Main terminal part screw : M4	1.5	1.7	2.0	INTIII
m	mass	-	-	260	1	g

#### RECOMMENDED CONDITIONS FOR USE

Symbol	Parameter	Conditions	Recommended value	Unit
V <sub>CC</sub>	Supply Voltage	Applied across P-N terminals	≤ 800	V
V <sub>D</sub>	Control Supply Voltage	Applied between:  VUP1-VUPC, VVP1-VVPC, VWP1-VWPC, VN1-VNC (Note4)	15.0±1.5	٧
V <sub>CIN(ON)</sub>	Input ON Voltage	Applied between :	≤ 0.8	V
V <sub>CIN(OFF)</sub>	Input OFF Voltage	$U_{P}$ - $V_{UPC}$ , $V_{P}$ - $V_{VPC}$ , $W_{P}$ - $V_{WPC}$ , $U_{N}$ , $V_{N}$ , $W_{N}$ - $V_{NC}$	≥ 9.0	V
f <sub>PWM</sub>	PWM Input Frequency	Using Application Circuit of Fig. 8	≤ 20	kHz
t <sub>dead</sub>	Arm Shoot-through Blocking Time	For IPM's each input signals (Fig.7)	≥ 2.5	μs

This product is compliant with the Restriction of the Use of Certain Hazardous Substances in Electrical and Electronic Equipment (RoHS) directive 2011/65/EU.

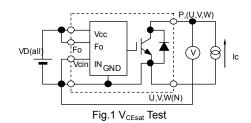
Note4. With ripple satisfying the following conditions: dv/dt swing ≤ ±5 V/µs, Variation ≤ 2 V peak to peak



#### PRECAUTIONS FOR TESTING

- 1. Before applying any control supply voltage (V<sub>D</sub>), the input terminals should be pulled up by resistors, etc. to their corresponding supply voltage and each input signal should be kept off state.
  - After this, the specified ON and OFF level setting for each input signal should be done.
- 2. When performing "SC" tests, the turn-off surge voltage spike at the corresponding protection operation should not be allowed to rise above V<sub>CES</sub> rating of the device.

(These test should not be done by using a curve tracer or its equivalent.)



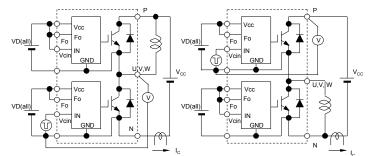
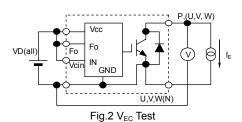


Fig.3 Switching time and SC test circuit



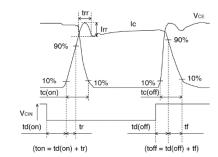


Fig.4 Switching time test waveform

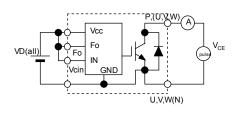


Fig.5 I<sub>CES</sub> Test

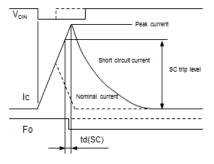
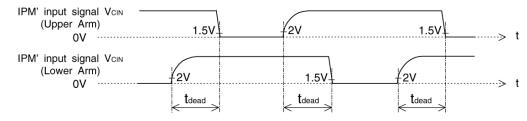


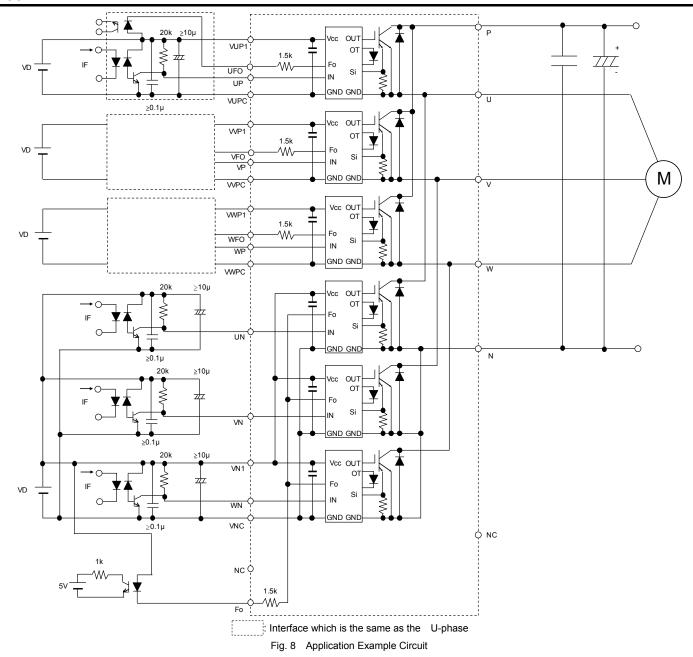
Fig.6 SC test waveform



1.5V: Input on threshold voltage Vth(on) typical value, 2V: Input off threshold voltage Vth(off) typical value

Fig. 7 Dead time measurement point example

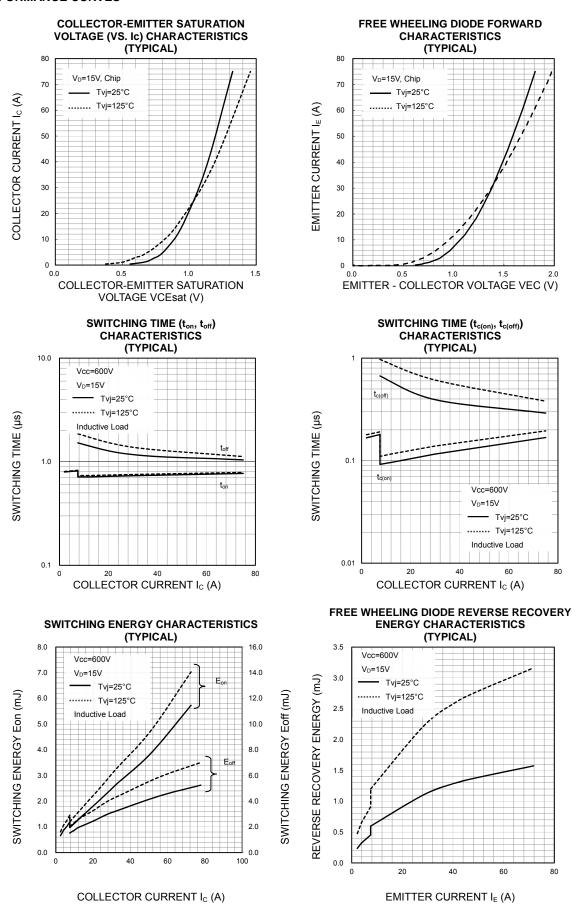
**INSULATED TYPE** 



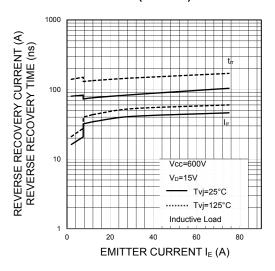
#### NOTES FOR STABLE AND SAFE OPERATION;

- Design the PCB pattern to minimize wiring length between opto-coupler and IPM's input terminal, and also to minimize the stray capacity between the input and output wirings of opto-coupler.
- · Connect low impedance capacitor between the Vcc and GND terminal of each fast switching opto-coupler.
- Fast switching opto-couplers:  $t_{PLH}$ ,  $t_{PHL} \le 0.8 \mu s$ , Use High CMR type.
- Slow switching opto-coupler: CTR > 100%
- $\bullet \ \ \text{Use 4 isolated control power supplies ($V_D$)}. \ Also, care should be taken to minimize the instantaneous voltage charge of the power supply.$
- Make inductance of DC bus line as small as possible, and minimize surge voltage using snubber capacitor between P and N terminal.

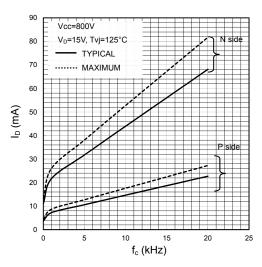
#### PERFORMANCE CURVES



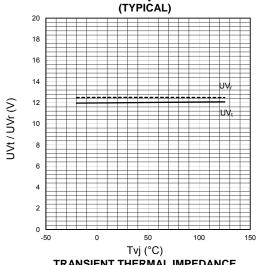
#### FREE WHEELING DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



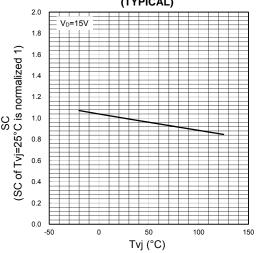
ID VS. fc CHARACTERISTICS (TYPICAL, MAXIMUM)



# UV TRIP LEVEL VS. Tvj CHARACTERISTICS (TYPICAL)



SC TRIP LEVEL VS. Tvj CHARACTERISTICS (TYPICAL)



#### TRANSIENT THERMAL IMPEDANCE **CHARACTERISTICS** (TYPICAL)

ш	i	1	2	3	4
Ş	Ri	0.0124	0.0739	0.3505	0.5632
\(\frac{1}{2}\)	ті (sec)	1.961E-05	0.0014	0.0179	0.0944
NORMARIZED TRANSIENT THERMAL IMPEDANCE Zth(j-c)	10				
≥					
<b>₩</b>					
Z.	1				
置()					
- - - - -					
点	0.1				
N N		/			
꽃					
		Singl	e Pulse		
Z	0.01	IGB	T Part;		
ĮĄ.			unit base: R D Part;	th(j-c)Q=0.2	6K/W
ᇫ				th(j-c)D=0.3	8K /W
9	0.001				
	0.00001	0.0001 0.0		0.1	1 10
			TIME (s)		

HIGH POWER SWITCHING USE INSULATED TYPE

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